

Fraunhofer

TESTED® DEVICE

J. Schmalz GmbH SWGm-6S 146x146x65 **Report No. SC 1606-831**

Statement of Qualification

Particle Emission





Statement of Qualification

Customer J. Schmalz GmbH

Aacher Strasse 29 72293 Glatten Germany

Component tested

Category: Process Equipment

Subcategory: Vacuum Components

Product name: Wafer gripper SWGm-6S 146x146x65

(material code: PEEK; article number: 10.01.30.00138; material type: assembly with PEEK suction surface)

Random sampling of particle emissions (airborne) at representative sites

Standards/Guidelines:

Test devices:

Test environment parameters:

Test procedure parameters:

VDI 2083-9.1; ISO 14644-1

The norms stated generally refer to the version valid at the time of the tests.

Optical particle counter:

LasAir II 110 and LasAir III 110 with measuring ranges \geq 0.1 μ m, \geq 0.2 μ m, \geq 0.3 μ m, \geq 0.5 μ m, \geq 1.0 μ m and \geq 5.0 μ m

 Cleanroom Air Cleanliness Class (acc 	cording to ISO 14644-1):ISO 1
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•	Airflow velocity:				0.45 m/s
•	Airflow pattern:			vertical la	minar flow

• Temperature: 22°C±0.5°C

• Operating pressure: 6 bar (ultra-pure compressed air)

• Release time: 8 s

Test result/Classification

When operated under the specified test conditions, the wafer gripper SWGm-6S 146x146x65 is suitable for use in cleanrooms fulfilling the specifications of the following Air Cleanliness Class according to ISO 14644-1:

Test parameter(s)	Air Cleanliness Class
operating pressure = 6 bar (ultra-pure compressed air) evacuation time = 12 s release time = 8 s cycles per minute = 3	1
Overall result	1

The concentration of particles in the handling area of the gripper is directly dependent on the quality of the compressed air and the pneumatic components used to operate the ejectors. In order to handle cleanliness-sensitive products and to maintain the integrity of the surrounding cleanroom, venting of compressed air into the handling area of the gripper must be avoided.

The measuring devices used for the qualification tests are calibrated at regular intervals; their results can be traced back to national and international standards. In cases where no national standards exist, the test procedure implemented complies with the technical regulations and norms applicable at the time of the test. The relevant documentation can be viewed on request at any time.

For further information about the test environment and parameters, please refer to the Fraunhofer IPA test report.

Fraunhofer Institute for Manufacturing Engineering and Automation IPA

Department of Ultraclean Technology and Micromanufacturing

Nobelstrasse 12 70569 Stuttgart Germany Stuttgart, October 10, 2016

Place, date of first document issued

on behalf of Frank Rürger Project Manager Fraunhofer IPA

This document only applies to the named product in an unchanged state and is valid from the date of issue for a period of 5 years. The document can be verified under www.tested-device.com.



